













LP5907 SNVS798L-APRIL 2012-REVISED SEPTEMBER 2016

# LP5907 250-mA Ultra-Low-Noise, Low-Io LDO

#### **Features**

Input Voltage Range: 2.2 V to 5.5 V Output Voltage Range: 1.2 V to 4.5 V

Output Current: 250 mA

Stable with 1-µF Ceramic Input and Output

No Noise Bypass Capacitor Required

Remote Output Capacitor Placement

Thermal-Overload and Short-Circuit Protection

-40°C to 125°C Junction Temperature Range for

Low Output Voltage Noise: < 6.5 μV<sub>RMS</sub>

PSRR: 82 dB at 1 kHz

Output Voltage Tolerance: ±2% Virtually Zero IQ (Disabled): < 1 μA

Very Low I<sub>Ω</sub> (Enabled): 12 μA

Start-up Time: 80 µs

Low Dropout: 120 mV (typical)

# **Applications**

- Mobile Phones, Tablets
- Digital Cameras and Audio Devices
- Portable and Battery-Powered Equipment
- Portable Medical Equipment
- **Smart Meters**
- RF, PLL, VCO, and Clock Power Supplies
- **IP Cameras**
- **Drones**
- Field Transmitters

# 3 Description

The LP5907 is a low-noise LDO that can supply up to 250 mA output current. Designed to meet the requirements of RF and analog circuits, the LP5907 device provides low noise, high PSRR, low quiescent current, and low line or load transient response figures. Using new innovative design techniques, the LP5907 offers class-leading noise performance without a noise bypass capacitor and the ability for remote output capacitor placement.

The device is designed to work with a 1-µF input and a 1-µF output ceramic capacitor (no separate noise bypass capacitor is required).

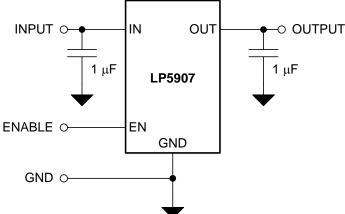
This device is available with fixed output voltages from 1.2 V to 4.5 V in 25-mV steps. Contact Texas Instruments Sales for specific voltage option needs.

# Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE				
	DSBGA (4)	0.675 mm × 0.675 mm (MAX)				
LP5907	SOT-23 (5)	2.90 mm × 1.60 mm (NOM)				
	X2SON (4)	1.00 mm × 1.00 mm (NOM)				

(1) For all available packages, see the orderable addendum at the end of the data sheet.

# Simplified Schematic



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# 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision K (May 2016) to Revision L	Page
Changed title of data sheet and updated list of Applications	1
Changed "10 μV <sub>RMS</sub> " to "6.5 μV <sub>RMS</sub> "	1
Changed wording of first sentence of Description	
Changes from Revision J (March 2016) to Revision K	Page
Changed "Linear Regulator" to "LDO" in title and first sentence of Description	1
Changes from Revision I (August 2015) to Revision J	Page
Changes from Revision I (August 2015) to Revision J  Changed V <sub>OUT</sub> min and max values and V <sub>EN</sub> min value in Abs Max table and V <sub>EN</sub> row of RO errors; replace text of footnote 2 of Abs Max table	
Changed V <sub>OUT</sub> min and max values and V <sub>EN</sub> min value in Abs Max table and V <sub>EN</sub> row of R0 errors; replace text of footnote 2 of Abs Max table	OC table to correct format 4
Changed V <sub>OUT</sub> min and max values and V <sub>EN</sub> min value in Abs Max table and V <sub>EN</sub> row of R0 errors; replace text of footnote 2 of Abs Max table	OC table to correct format4 Page
Changed V <sub>OUT</sub> min and max values and V <sub>EN</sub> min value in Abs Max table and V <sub>EN</sub> row of R0 errors; replace text of footnote 2 of Abs Max table	OC table to correct format  Page  All Characteristics
errors; replace text of footnote 2 of Abs Max table	Page  Characteristics

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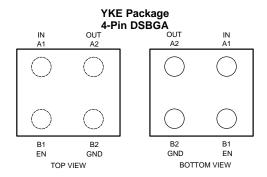
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Added Device Information and Handling Rating tables, Feature Description, Device Functional Modes, Application

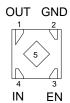
and Implementation, Power Supply Recommendations, Layout, Device and Documentation Support, and



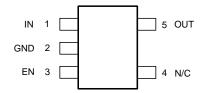
# 5 Pin Configuration and Functions







#### DBV Package 5-Pin SOT-23 Top View



### **Pin Functions**

i iii i uiiotioiio								
PIN								
NAME	DSBGA NUMBER	X2SON NUMBER	SOT-23 NUMBER	I/O	DESCRIPTION			
IN	A1	4	1	I	Input voltage supply. A $1-\mu F$ capacitor should be connected at this input.			
OUT	A2	1	5	0	Regulated output voltage. A minimum 1- $\mu$ F low-ESR capacitor should be connected to this pin. Connect this output to the load circuit. An internal 230- $\Omega$ (typical) pulldown resistor prevents a charge remaining on V <sub>OUT</sub> when the regulator is in the shutdown mode (V <sub>EN</sub> low).			
EN	B1	3	3	I	Enable input. A low voltage ( $<$ V $_{IL}$ ) on this pin turns the regulator off and discharges the output pin to GND through an internal 230- $\Omega$ pulldown resistor. A high voltage ( $>$ V $_{IH}$ ) on this pin enables the regulator output. This pin has an internal 1M- $\Omega$ pulldown resistor to hold the regulator off by default.			
GND	B2	2	2	_	Common ground			
N/C	N/A	N/A	4	_	No internal electrical connection.			
Thermal Pad	N/A	5	N/A	_	Thermal pad for X2SON package, connect to GND or leave floating. Do not connect to any potential other than GND.			



# 6 Specifications

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)(2)

		MIN	MAX	UNIT
V <sub>IN</sub>	Input voltage	-0.3	6	
V <sub>OUT</sub>	Output voltage	-0.3	See <sup>(3)</sup>	V
V <sub>EN</sub>	Enable input voltage	-0.3	6	
	Continuous power dissipation (4)	Internally	Limited	W
T <sub>JMAX</sub>	Junction temperature		150	°C
T <sub>stg</sub>	Storage temperature	-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- (2) All voltages are with respect to the GND pin.
- 3) Abs Max V<sub>OUT</sub> is the lessor of V<sub>IN</sub> + 0.3 V, or 6 V.
- (4) Internal thermal shutdown circuitry protects the device from permanent damage.

# 6.2 ESD Ratings

			VALUE	UNIT
V	Floatroototic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±2000	\/
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 (2)	±1000	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

# 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted) (1)(2)

		MIN	MAX	UNIT
$V_{IN}$	Input supply voltage	2.2	5.5	\/
$V_{EN}$	Enable input voltage	0	5.5	V
I <sub>OUT</sub>	Output current	0	250	mA
$T_{J}$	Junction temperature	-40	125	°C
T <sub>A</sub>	Ambient temperature (3)	-40	85	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

<sup>(2)</sup> All voltages are with respect to the GND pin.

<sup>(3)</sup> In applications where high power dissipation and/or poor package thermal resistance is present, the maximum ambient temperature may have to be derated. Maximum ambient temperature (T<sub>A-MAX</sub>) is dependent on the maximum operating junction temperature (T<sub>J-MAX-OP</sub> = 125°C), the maximum power dissipation of the device in the application (P<sub>D-MAX</sub>), and the junction-to ambient thermal resistance of the part/package in the application (R<sub>θJA</sub>), as given by the following equation: T<sub>A-MAX</sub> = T<sub>J-MAX-OP</sub> - (R<sub>θJA</sub> × P<sub>D-MAX</sub>). See Applications and Implementation.



#### 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		DBV (SOT-23)	DQN (X2SON)	YKE (DSBGA)	UNIT
		5 PINS	4 PINS	4 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	193.4	216.1	206.1	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	102.1	161.7	1.5	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	45.8	162.1	37.0	°C/W
ΨЈТ	Junction-to-top characterization parameter	8.4	5.1	15.0	°C/W
ΨЈВ	Junction-to-board characterization parameter	45.3	161.7	36.8	°C/W
R <sub>0</sub> JC(bot)	Junction-to-case (bottom) thermal resistance	n/a	123.0	n/a	°C/W

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

### 6.5 Electrical Characteristics

 $V_{IN} = V_{OUT(NOM)} + 1 \text{ V}, V_{EN} = 1.2 \text{ V}, I_{OUT} = 1 \text{ mA}, C_{IN} = 1 \mu\text{F}, C_{OUT} = 1 \mu\text{F}, unless otherwise stated.}$ 

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>IN</sub>	Input voltage	T <sub>A</sub> = 25°C	2.2		5.5	V
		$V_{IN} = (V_{OUT(NOM)} + 1 \text{ V}) \text{ to } 5.5 \text{ V},$ $I_{OUT} = 1 \text{ mA to } 250 \text{ mA}$	-2		2	
$\Delta V_{OUT}$	Output voltage tolerance	V <sub>IN</sub> = (V <sub>OUT(NOM)</sub> + 1 V) to 5.5 V, I <sub>OUT</sub> = 1 mA to 250 mA (V <sub>OUT</sub> < 1.8 V, SOT-23, X2SON packages)	-3		3	%V <sub>OUT</sub>
	Line regulation	$V_{IN} = (V_{OUT(NOM)} + 1 \text{ V}) \text{ to } 5.5 \text{ V},$ $I_{OUT} = 1 \text{ mA}$		0.02		%/V
	Load regulation	I <sub>OUT</sub> = 1 mA to 250 mA		0.001		%/mA
-	Load current	See <sup>(4)</sup>	0		250	mA
I <sub>LOAD</sub>	Maximum output current		250			
	Quiescent current <sup>(5)</sup>	V <sub>EN</sub> = 1.2 V, I <sub>OUT</sub> = 0 mA		12	25	
$I_Q$		V <sub>EN</sub> = 1.2 V, I <sub>OUT</sub> = 250 mA		250	425	μA
		V <sub>EN</sub> = 0.3 V (Disabled)		0.2	1	
I <sub>G</sub>	Ground current <sup>(6)</sup>	V <sub>EN</sub> = 1.2 V, I <sub>OUT</sub> = 0 mA		14		μA
		I <sub>OUT</sub> = 100 mA		50		
$V_{DO}$	Dropout voltage (7)	I <sub>OUT</sub> = 250 mA (DSBGA package)		120	200	mV
		I <sub>OUT</sub> = 250 mA (SOT-23, X2SON packages)			250	
I <sub>SC</sub>	Short circuit current limit	$T_A = 25^{\circ}C^{(8)}$	250	500		mA
		f = 100 Hz, I <sub>OUT</sub> = 20 mA		90		
DODD	(9)	f = 1 kHz, I <sub>OUT</sub> = 20 mA		82		ı.D
PSRR	Power supply rejection ratio (9)	f = 10 kHz, I <sub>OUT</sub> = 20 mA		65		dB
		f = 100 kHz, I <sub>OUT</sub> = 20 mA		60		

- (1) All voltages are with respect to the device GND terminal, unless otherwise stated.
- (2) Minimum and maximum limits are ensured through test, design, or statistical correlation over the junction temperature (T<sub>J</sub>) range of -40°C to 125°C, unless otherwise stated. Typical values represent the most likely parametric norm at T<sub>A</sub> = 25°C, and are provided for reference purposes only.
- (3) In applications where high power dissipation and/or poor package thermal resistance is present, the maximum ambient temperature may have to be derated. Maximum ambient temperature (T<sub>A-MAX</sub>) is dependent on the maximum operating junction temperature (T<sub>J-MAX-OP</sub> = 125°C), the maximum power dissipation of the device in the application (P<sub>D-MAX</sub>), and the junction-to ambient thermal resistance of the part/package in the application R<sub>θJA</sub>), as given by the following equation: T<sub>A-MAX</sub> = T<sub>J-MAX-OP</sub> (R<sub>θJA</sub> × P<sub>D-MAX</sub>). See Applications and Implementation.
- (4) The device maintains a stable, regulated output voltage without a load current.
- 5) Quiescent current is defined here as the difference in current between the input voltage source and the load at V<sub>OUT</sub>.
- (6) Ground current is defined here as the total current flowing to ground as a result of all input voltages applied to the device.
- (7) Dropout voltage is the voltage difference between the input and the output at which the output voltage drops to 100 mV below its nominal value.
- (8) Short-circuit current (I<sub>SC</sub>) for the LP5907 is equivalent to current limit. To minimize thermal effects during testing, I<sub>SC</sub> is measured with V<sub>OUT</sub> pulled to 100 mV below its nominal voltage.
- 9) This specification is verified by design.



## **Electrical Characteristics (continued)**

 $V_{IN} = V_{OUT(NOM)} + 1 \text{ V}, V_{EN} = 1.2 \text{ V}, I_{OUT} = 1 \text{ mA}, C_{IN} = 1 \text{ } \mu\text{F}, C_{OUT} = 1 \text{ } \mu\text{F}, unless otherwise stated.}$ 

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
e <sub>N</sub>	Output noise voltage (9)	BW = 10 Hz to 100 kHz			10		$\mu V_{RMS}$
ON.	- Calpat Helee Vollage	DTT = 10 112 to 100 til 12	$I_{OUT} = 250 \text{ mA}$		6.5		PIRIVIS
R <sub>AD</sub>	Output Automatic Discharge pulldown resistance	V <sub>EN</sub> < V <sub>IL</sub> (output disabled	)		230		Ω
_	Thermal shutdown	T <sub>J</sub> rising			160		°C
T <sub>SD</sub>	Thermal hysteresis	T <sub>J</sub> falling from shutdown			15		
LOGIC IN	IPUT THRESHOLDS						
V <sub>IL</sub>	Low input threshold	V <sub>IN</sub> = 2.2 V to 5.5 V V <sub>EN</sub> falling until the output	is disabled			0.4	V
V <sub>IH</sub>	High input threshold	V <sub>IN</sub> = 2.2 V to 5.5 V V <sub>EN</sub> rising until the output is enabled		1.2			V
	Input current at EN pin (10)	$V_{EN}$ = 5.5 V and $V_{IN}$ = 5.5 V			5.5		
I <sub>EN</sub>	input current at EN pin (**)	$V_{EN} = 0 \text{ V}$ and $V_{IN} = 5.5 \text{ V}$		0.001			μA
TRANSIE	ENT CHARACTERISTICS						
	Line transient <sup>(9)</sup>	$V_{IN} = (V_{OUT(NOM)} + 1 V)$ to $(V_{OUT(NOM)} + 1.6 V)$ in 30	μs	-1			mV
$\Delta V_{OUT}$	Line transiente?	V <sub>IN</sub> = (V <sub>OUT(NOM)</sub> + 1.6 V) to (V <sub>OUT(NOM)</sub> + 1.6 V) in 30 µs				1	IIIV
	Load transient <sup>(9)</sup>	$I_{OUT} = 1$ mA to 250 mA in	10 µs	-40			\/
	Load transient	I <sub>OUT</sub> = 250 mA to 1mA in 10 μs				40	mV
	Overshoot on start-up (9)	Stated as a percentage of V <sub>OUT(NOM)</sub>				5%	
t <sub>ON</sub>	Turnon time	From $V_{EN} > V_{IH}$ to $V_{OUT} = T_A = 25^{\circ}C$	95% of V <sub>OUT(NOM)</sub>		80	150	μs

<sup>(10)</sup> There is a 1-M  $\!\Omega\!$  resistor between EN and ground on the device.

## 6.6 Output and Input Capacitors

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN <sup>(1)</sup>	TYP	MAX	UNIT
C <sub>IN</sub>	Input capacitance (2)	Canacitanas for atability	0.7	1		μF
C <sub>OUT</sub>	Output capacitance (2)	Capacitance for stability	0.7	1	10	μF
ESR	Output/Input capacitance (2)		5		500	mΩ

<sup>(1)</sup> The minimum capacitance should be greater than 0.5 μF over the full range of operating conditions. The capacitor tolerance should be 30% or better over the full temperature range. The full range of operating conditions for the capacitor in the application must be considered during device selection to ensure this minimum capacitance specification is met. X7R capacitors are recommended however capacitor types X5R, Y5V and Z5U may be used with consideration of the application and conditions.

(2) This specification is verified by design.

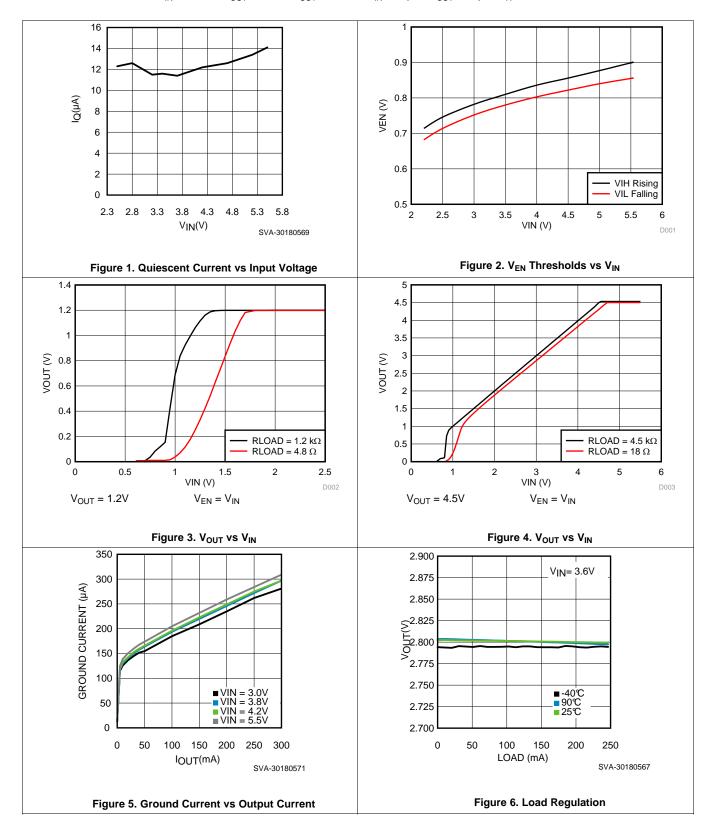
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# 6.7 Typical Characteristics

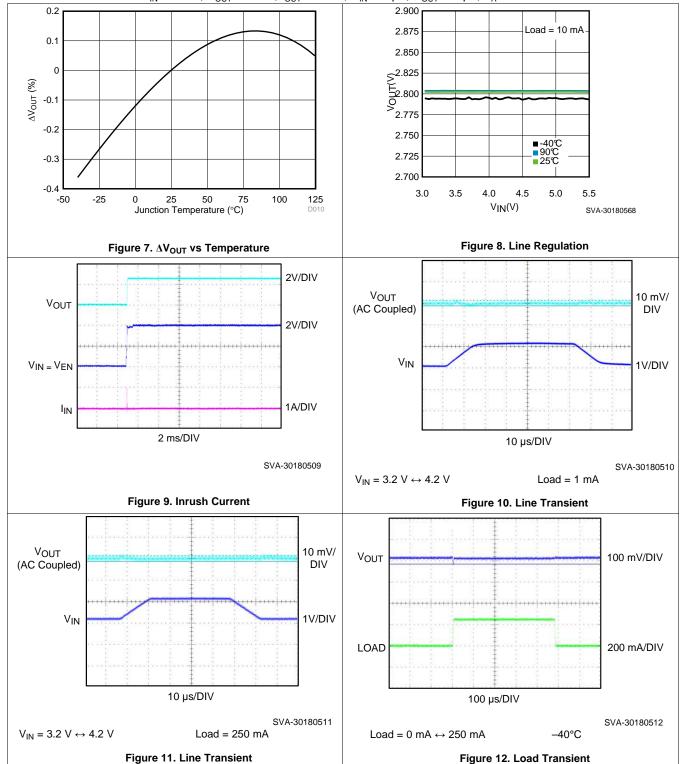
Unless otherwise stated: V<sub>IN</sub> = 3.7 V, V<sub>OUT</sub> = 2.8 V, I<sub>OUT</sub> = 1 mA, C<sub>IN</sub> = 1  $\mu$ F, C<sub>OUT</sub> = 1  $\mu$ F, T<sub>A</sub> = 25°C



# TEXAS INSTRUMENTS

# **Typical Characteristics (continued)**

Unless otherwise stated:  $V_{IN} = 3.7 \text{ V}$ ,  $V_{OUT} = 2.8 \text{ V}$ ,  $I_{OUT} = 1 \text{ mA}$ ,  $C_{IN} = 1 \mu\text{F}$ ,  $C_{OUT} = 1 \mu\text{F}$ ,  $T_A = 25 ^{\circ}\text{C}$ 



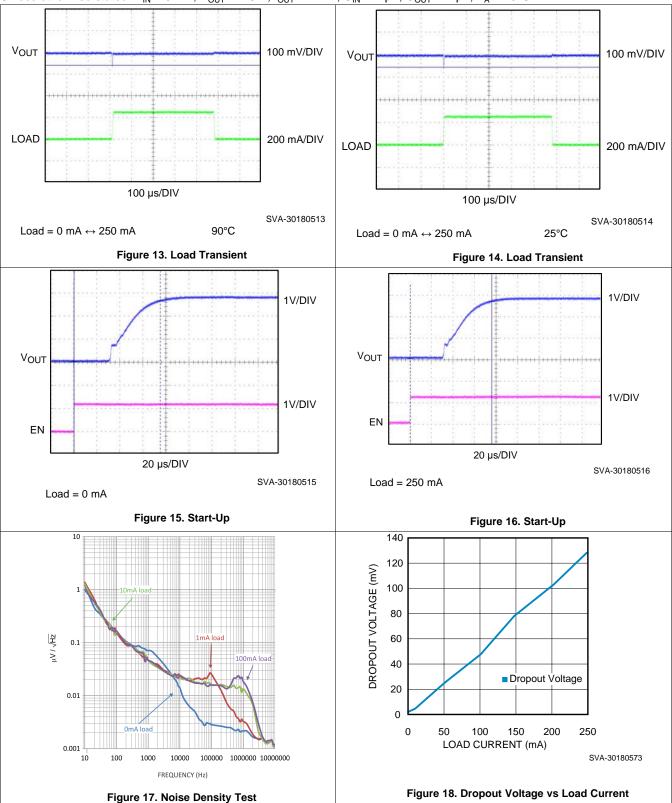
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# **Typical Characteristics (continued)**

Unless otherwise stated:  $V_{IN} = 3.7 \text{ V}$ ,  $V_{OUT} = 2.8 \text{ V}$ ,  $I_{OUT} = 1 \text{ mA}$ ,  $C_{IN} = 1 \text{ }\mu\text{F}$ ,  $C_{OUT} = 1 \text{ }\mu\text{F}$ ,  $T_A = 25 ^{\circ}\text{C}$ 



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250 mA

200 mA 150 mA 100 mA

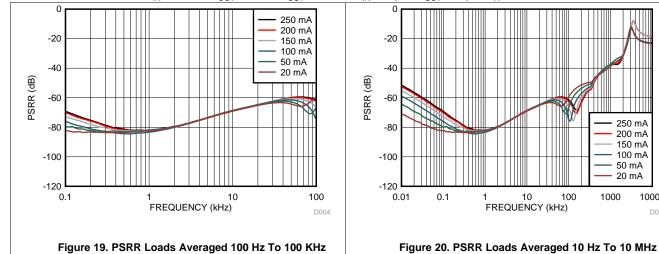
50 mA 20 mA

10000

1000

# **Typical Characteristics (continued)**

Unless otherwise stated:  $V_{IN}$  = 3.7 V,  $V_{OUT}$  = 2.8 V,  $I_{OUT}$  = 1 mA,  $C_{IN}$  = 1  $\mu$ F,  $C_{OUT}$  = 1  $\mu$ F,  $T_A$  = 25°C





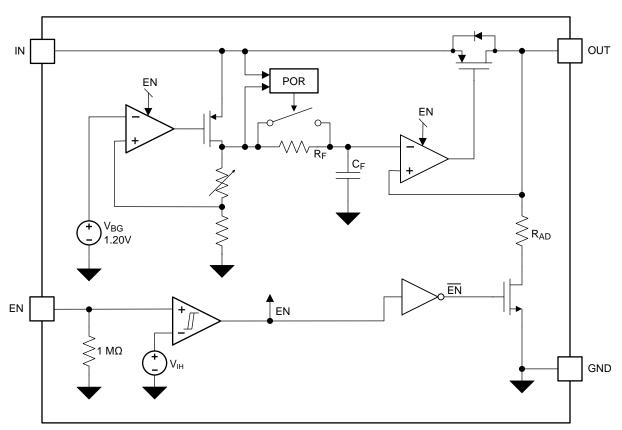
## 7 Detailed Description

#### 7.1 Overview

Designed to meet the needs of sensitive RF and analog circuits, the LP5907 provides low noise, high PSRR, low quiescent current, as well as low line and load transient response figures. Using new innovative design techniques, the LP5907 offers class leading noise performance without the need for a separate noise filter capacitor.

The LP5907 is designed to perform with a single 1- $\mu$ F input capacitor and a single 1- $\mu$ F ceramic output capacitor. With a reasonable PCB layout, the single 1- $\mu$ F ceramic output capacitor can be placed up to 10 cm away from the LP5907 device.

## 7.2 Functional Block Diagram



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### 7.3 Feature Description

#### 7.3.1 Enable (EN)

The LP5907 EN pin is internally held low by a 1-M $\Omega$  resistor to GND. The EN pin voltage must be higher than the V<sub>IH</sub> threshold to ensure that the device is fully enabled under all operating conditions. The EN pin voltage must be lower than the V<sub>IL</sub> threshold to ensure that the device is fully disabled and the automatic output discharge is activated.

# 7.3.2 Low Output Noise

Any internal noise at the LP5907 reference voltage is reduced by a first order low-pass RC filter before it is passed to the output buffer stage. The low-pass RC filter has a -3 dB cut-off frequency of approximately 0.1 Hz.

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## **Feature Description (continued)**

#### 7.3.3 Output Automatic Discharge

The LP5907 output employs an internal 230- $\Omega$  (typical) pulldown resistance to discharge the output when the EN pin is low, and the device is disabled.

#### 7.3.4 Remote Output Capacitor Placement

The LP5907 requires at least a  $1-\mu F$  capacitor at the OUT pin, but there are no strict requirements about the location of the capacitor in regards the OUT pin. In practical designs, the output capacitor may be located up to 10 cm away from the LDO.

# 7.3.5 Thermal Overload Protection (T<sub>SD</sub>)

Thermal shutdown disables the output when the junction temperature rises to approximately 160°C which allows the device to cool. When the junction temperature cools to approximately 145°C, the output circuitry enables. Based on power dissipation, thermal resistance, and ambient temperature, the thermal protection circuit may cycle on and off. This thermal cycling limits the dissipation of the regulator and protects it from damage as a result of overheating.

The thermal shutdown circuitry of the LP5907 has been designed to protect against temporary thermal overload conditions. The T<sub>SD</sub> circuitry was not intended to replace proper heat-sinking. Continuously running the LP5907 device into thermal shutdown may degrade device reliability.

#### 7.4 Device Functional Modes

#### 7.4.1 Enable (EN)

The LP5907 Enable (EN) pin is internally held low by a 1-M $\Omega$  resistor to GND. The EN pin voltage must be higher than the V<sub>IH</sub> threshold to ensure that the device is fully enabled under all operating conditions.

When the EN pin is pulled low, and the output is disabled, the output automatic discharge circuitry is activated. Any charge on the OUT pin is discharged to GND through the internal  $230-\Omega$  (typical) pulldown resistance.

#### 7.4.2 Minimum Operating Input Voltage (V<sub>IN</sub>)

The LP5907 does not include any dedicated UVLO circuitry. The LP5907 internal circuitry is not fully functional until  $V_{IN}$  is at least 2.2 V. The output voltage is not regulated until  $V_{IN}$  has reached at least the greater of 2.2 V or  $(V_{OLIT} + V_{DO})$ .



# 8 Applications and Implementation

#### NOTE

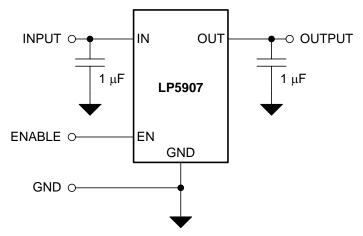
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

# 8.1 Application Information

The LP5907 is designed to meet the requirements of RF and analog circuits, by providing low noise, high PSRR, low quiescent current, and low line or load transient response figures. The device offers excellent noise performance without the need for a noise bypass capacitor and is stable with input and output capacitors with a value of 1  $\mu$ F. The LP5907 delivers this performance in industry standard packages such as DSBGA, X2SON, and SOT-23 which, for this device, are specified with an operating junction temperature (T<sub>J</sub>) of -40°C to 125°C.

### 8.2 Typical Application

Figure 21 shows the typical application circuit for the LP5907. Input and output capacitances may need to be increased above the 1 µF minimum for some applications.



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Figure 21. LP5907 Typical Application

#### 8.2.1 Design Requirements

DESIGN PARAMETER	EXAMPLE VALUE					
Input voltage range	2.2 V to 5.5 V					
Output voltage	1.8 V					
Output current	200 mA					
Output capacitor range	0.7 μF to 10 μF					
Input/Output capacitor ESR range	5 to 500 mΩ					

#### 8.2.2 Detailed Design Procedure

#### 8.2.2.1 Power Dissipation and Device Operation

The permissible power dissipation for any package is a measure of the capability of the device to pass heat from the power source, the junctions of the IC, to the ultimate heat sink, the ambient environment. Thus, the power dissipation is dependent on the ambient temperature and the thermal resistance across the various interfaces between the die junction and ambient air.



The maximum allowable power dissipation for the device in a given package can be calculated using Equation 1:

$$P_{D-MAX} = ((T_{J-MAX} - T_A) / R_{\theta JA})$$
 (1)

The actual power being dissipated in the device can be represented by Equation 2:

$$P_{D} = (V_{IN} - V_{OUT}) \times I_{OUT}$$
 (2)

These two equations establish the relationship between the maximum power dissipation allowed due to thermal consideration, the voltage drop across the device, and the continuous current capability of the device. These two equations should be used to determine the optimum operating conditions for the device in the application.

In applications where lower power dissipation ( $P_D$ ) and/or excellent package thermal resistance ( $R_{\theta JA}$ ) is present, the maximum ambient temperature ( $T_{A-MAX}$ ) may be increased.

In applications where high power dissipation and/or poor package thermal resistance is present, the maximum ambient temperature ( $T_{A-MAX}$ ) may have to be derated.  $T_{A-MAX}$  is dependent on the maximum operating junction temperature ( $T_{J-MAX-OP} = 125$ °C), the maximum allowable power dissipation in the device package in the application ( $P_{D-MAX}$ ), and the junction-to ambient thermal resistance of the part/package in the application ( $R_{\theta JA}$ ), as given by Equation 3:

$$T_{A-MAX} = (T_{J-MAX-OP} - (R_{\theta JA} \times P_{D-MAX}))$$
(3)

Alternately, if  $T_{A-MAX}$  can not be derated, the  $P_D$  value must be reduced. This can be accomplished by reducing  $V_{IN}$  in the  $V_{IN}\!-\!V_{OUT}$  term as long as the minimum  $V_{IN}$  is met, or by reducing the  $I_{OUT}$  term, or by some combination of the two.

#### 8.2.2.2 External Capacitors

Like most low-dropout regulators, the LP5907 requires external capacitors for regulator stability. The device is specifically designed for portable applications requiring minimum board space and smallest components. These capacitors must be correctly selected for good performance.

### 8.2.2.3 Input Capacitor

An input capacitor is required for stability. The input capacitor should be at least equal to, or greater than, the output capacitor for good load transient performance. At least a 1  $\mu$ F capacitor has to be connected between the LP5907 input pin and ground for stable operation over full load current range. Basically, it is ok to have more output capacitance than input, as long as the input is at least 1  $\mu$ F.

The input capacitor must be located a distance of not more than 1 cm from the input pin and returned to a clean analog ground. Any good quality ceramic, tantalum, or film capacitor may be used at the input.

### NOTE

To ensure stable operation it is essential that good PCB practices are employed to minimize ground impedance and keep input inductance low. If these conditions cannot be met, or if long leads are to be used to connect the battery or other power source to the LP5907, TI recommends increasing the input capacitor to at least 10  $\mu F$ . Also, tantalum capacitors can suffer catastrophic failures due to surge current when connected to a low-impedance source of power (like a battery or a very large capacitor). If a tantalum capacitor is used at the input, it should be verified by the manufacturer to have a surge current rating sufficient for the application. The initial tolerance, applied voltage de-rating, and temperature coefficient must all be considered when selecting the input capacitor to ensure the actual capacitance is never less than 0.7  $\mu F$  over the entire operating range.

#### 8.2.2.4 Output Capacitor

The LP5907 is designed specifically to work with a very small ceramic output capacitor, typically 1  $\mu$ F. A ceramic capacitor (dielectric types X5R or X7R) in the 1  $\mu$ F to 10  $\mu$ F range, and with ESR between 5 m $\Omega$  to 500 m $\Omega$ , is suitable in the LP5907 application circuit. For this device the output capacitor should be connected between the OUT pin and a good connection back to the GND pin.

It may also be possible to use tantalum or film capacitors at the device output, V<sub>OUT</sub>, but these are not as attractive for reasons of size and cost (see *Capacitor Characteristics*).



The output capacitor must meet the requirement for the minimum value of capacitance and have an ESR value that is within the range  $5~\text{m}\Omega$  to  $500~\text{m}\Omega$  for stability. Like the input capacitor, the initial tolerance, applied voltage de-rating, and temperature coefficient must all be considered when selecting the input capacitor to ensure the actual capacitance is never less than 0.7~µF over the entire operating range.

#### 8.2.2.5 Capacitor Characteristics

The LP5907 is designed to work with ceramic capacitors on the input and output to take advantage of the benefits they offer. For capacitance values in the range of 1  $\mu$ F to 10  $\mu$ F, ceramic capacitors are the smallest, least expensive and have the lowest ESR values, thus making them best for eliminating high frequency noise. The ESR of a typical 1  $\mu$ F ceramic capacitor is in the range of 20 m $\Omega$  to 40 m $\Omega$ , which easily meets the ESR requirement for stability for the LP5907.

A better choice for temperature coefficient in a ceramic capacitor is X7R. This type of capacitor is the most stable and holds the capacitance within  $\pm 15\%$  over the temperature range. Tantalum capacitors are less desirable than ceramic for use as output capacitors because they are more expensive when comparing equivalent capacitance and voltage ratings in the 1  $\mu$ F to 10  $\mu$ F range.

Another important consideration is that tantalum capacitors have higher ESR values than equivalent size ceramics. This means that while it may be possible to find a tantalum capacitor with an ESR value within the stable range, it would have to be larger in capacitance (which means bigger and more costly) than a ceramic capacitor with the same ESR value. It should also be noted that the ESR of a typical tantalum increases about 2:1 as the temperature goes from 25°C down to -40°C, so some guard band must be allowed.

#### 8.2.2.6 Remote Capacitor Operation

The LP5907 requires at least a 1-µF capacitor at the OUT pin, but there is no strict requirements about the location of the capacitor in regards to the pin. In practical designs the output capacitor may be located up to 10 cm away from the LDO. This means that there is no need to have a special capacitor close to the output pin if there is already respective capacitors in the system (like a capacitor at the input of supplied part). The remote capacitor feature helps user to minimize the number of capacitors in the system.

As a good design practice, keep the wiring parasitic inductance at a minimum, which means to use as wide as possible traces from the LDO output to the capacitors, keeping the LDO output trace layer as close to ground layer as possible and avoiding vias on the path. If there is a need to use vias, implement as many as possible vias between the connection layers. The recommendation is to keep parasitic wiring inductance less than 35 nH. For the applications with fast load transients, it is recommended to use an input capacitor equal to or larger to the sum of the capacitance at the output node for the best load transient performance.

#### 8.2.2.7 No-Load Stability

The LP5907 remains stable, and in regulation, with no external load.

#### 8.2.2.8 Enable Control

The LP5907 may be switched ON or OFF by a logic input at the EN pin. A voltage on this pin greater than  $V_{IH}$  turns the device on, while a voltage less than  $V_{IL}$  turns the device off.

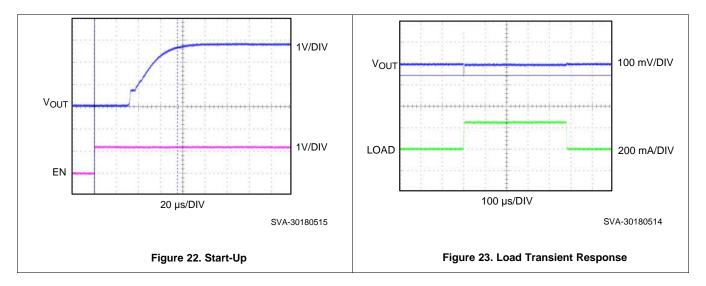
When the EN pin is low, the regulator output is off and the device typically consumes less than 1  $\mu$ A. Additionally, an output pulldown circuit is activated which ensures that any charge stored on  $C_{OUT}$  is discharged to ground.

If the application does not require the use of the shutdown feature, the EN pin can be tied directly to the IN pin to keep the regulator output permanently on.

An internal 1-M $\Omega$  pulldown resistor ties the EN input to ground, ensuring that the device remains off if the EN pin is left open circuit. To ensure proper operation, the signal source used to drive the EN pin must be able to swing above and below the specified turnon or turnoff voltage thresholds listed in the *Electrical Characteristics* under  $V_{IL}$  and  $V_{IH}$ .



#### 8.2.3 Application Curves



# 9 Power Supply Recommendations

This device is designed to operate from an input supply voltage range of 2.2 V to 5.5 V. The input supply must be well regulated and free of spurious noise. To ensure that the LP5907 output voltage is well regulated and dynamic performance is optimum, the input supply must be at least  $V_{OUT}$  + 1 V. A minimum capacitor value of 1  $\mu$ F is required to be within 1 cm of the IN pin.



# 10 Layout

## 10.1 Layout Guidelines

The dynamic performance of the LP5907 is dependant on the layout of the PCB. PCB layout practices that are adequate for typical LDOs may degrade the PSRR, noise, or transient performance of the LP5907.

Best performance is achieved by placing  $C_{\text{IN}}$  and  $C_{\text{OUT}}$  on the same side of the PCB as the LP5907, and as close to the package as is practical. The ground connections for  $C_{\text{IN}}$  and  $C_{\text{OUT}}$  must be back to the LP5907 ground pin using as wide and short a copper trace as is practical.

Connections using long trace lengths, narrow trace widths, and/or connections through vias must be avoided. These add parasitic inductances and resistance that results in inferior performance especially during transient conditions

### 10.2 Layout Examples

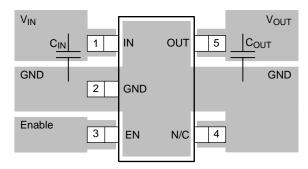


Figure 24. LP5907MF-x.x (SOT-23) Typical Layout

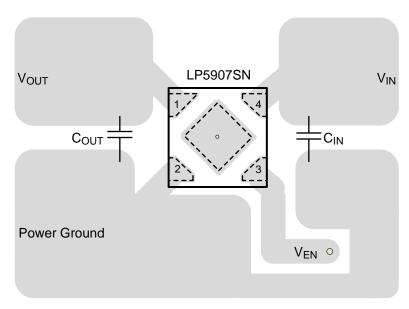


Figure 25. LP5907SN-xx (X2SON) Typical Layout

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## **Layout Examples (continued)**

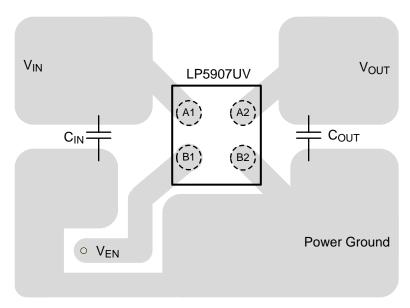


Figure 26. LP5907UV-x.x (DSBGA) Typical Layout

# 10.3 X2SON Mounting

The X2SON package thermal pad must be soldered to the printed circuit board for proper thermal and mechanical performance. For more information, see the Application Report QFN/SON PCB Attachment (SLUA271).

# 10.4 DSBGA Mounting

The DSBGA package requires specific mounting techniques, which are detailed in *AN-1112 DSBGA Wafer Level Chip Scale Package* (SNVA009). For best results during assembly, alignment ordinals on the PC board may be used to facilitate placement of the DSBGA device.

# 10.5 DSBGA Light Sensitivity

Exposing the DSBGA device to direct light may cause incorrect operation of the device. Light sources such as halogen lamps can affect electrical performance if they are situated in proximity to the device. Light with wavelengths in the red and infrared part of the spectrum have the most detrimental effect; thus, the fluorescent lighting used inside most buildings has very little effect on performance.



# 11 Device and Documentation Support

# 11.1 Documentation Support

#### 11.1.1 Related Documentation

For related documentation, see the following:

- AN-1112 DSBGA Wafer Level Chip Scale Package (SNVA009)
- Texas Instruments Application Report QFN/SON PCB Attachment (SLUA271)

## 11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

# 11.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 11.4 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

# 11.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# 11.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

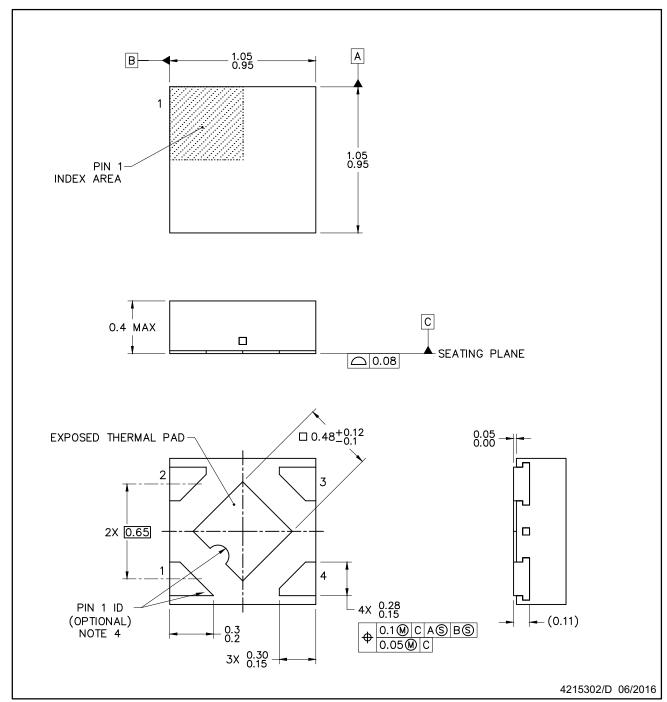


# **PACKAGE OUTLINE**

# **DQN0004A**

# X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



#### NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.
- 4. Features may not exist. Recommend use of pin 1 marking on top of package for orientation purposes.

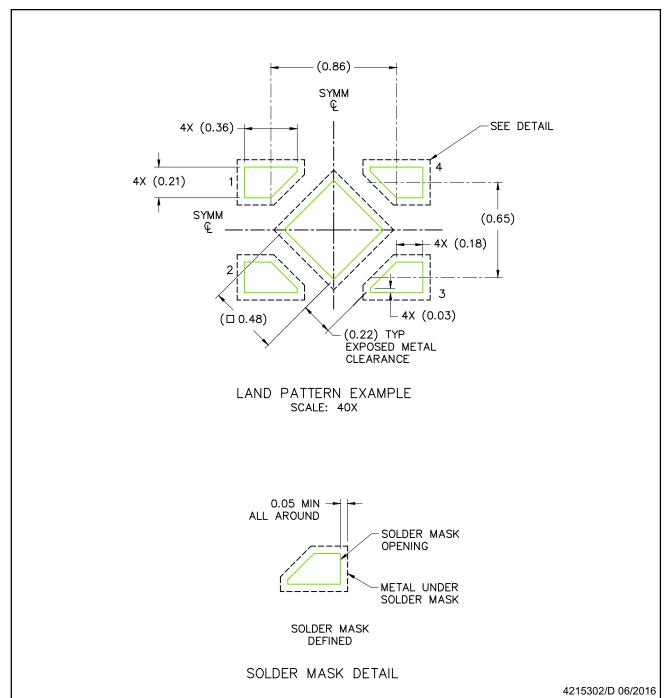


# **EXAMPLE BOARD LAYOUT**

# **DQN0004A**

# X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

- 5. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 6. If any vias are implemented, it is recommended that vias under paste be filled, plugged or tented.

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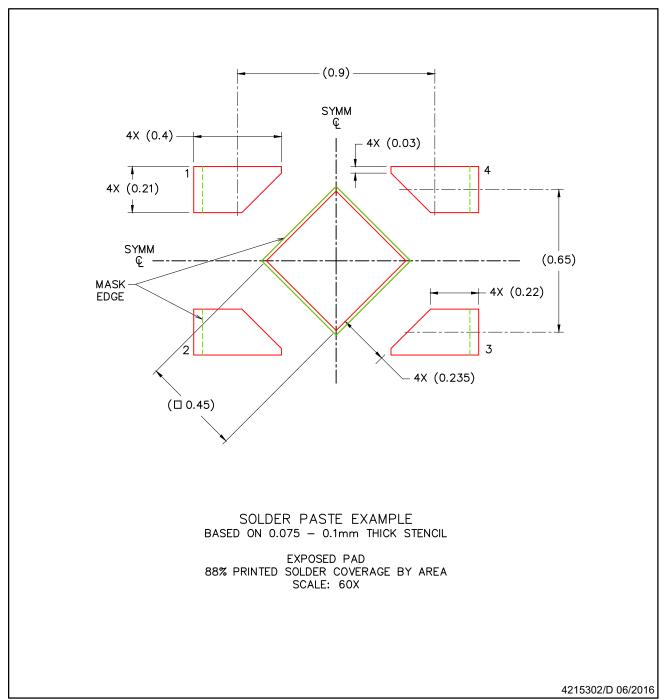


# **EXAMPLE STENCIL DESIGN**

# **DQN0004A**

# X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.





15-Apr-2017

# **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
LP5907MFX-1.2/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LLTB	Samples
LP5907MFX-1.5/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LN8B	Sample
LP5907MFX-1.8/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LLUB	Sample
LP5907MFX-2.5/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LN7B	Sample
LP5907MFX-2.8/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LLYB	Sample
LP5907MFX-2.85/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LN4B	Samples
LP5907MFX-3.0/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LLZB	Sample
LP5907MFX-3.1/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LN5B	Sample
LP5907MFX-3.2/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LN6B	Sample
LP5907MFX-3.3/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LLVB	Sample
LP5907MFX-4.5/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LLXB	Sample
LP5907SNX-1.2/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CF	Samples
LP5907SNX-1.8/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CG	Sample
LP5907SNX-1.9	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	3Z	Sample
LP5907SNX-2.2/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	EP	Sample
LP5907SNX-2.5/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	F9	Sample
LP5907SNX-2.7/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	СН	Sample





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Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
LP5907SNX-2.75	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	HI	Samples
LP5907SNX-2.8/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM -40 to 125		CI	Samples
LP5907SNX-2.85/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CJ	Samples
LP5907SNX-2.9/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	GV	Samples
LP5907SNX-3.0/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	СК	Samples
LP5907SNX-3.1/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CL	Samples
LP5907SNX-3.2/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	СМ	Samples
LP5907SNX-3.3/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CN	Samples
LP5907SNX-4.0/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	GU	Samples
LP5907SNX-4.5/NOPB	ACTIVE	X2SON	DQN	4	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	СО	Samples
LP5907UVE-1.2/NOPB	ACTIVE	DSBGA	YKE	4	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	R	Sample
LP5907UVE-1.8/NOPB	ACTIVE	DSBGA	YKE	4	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	S	Samples
LP5907UVE-2.8/NOPB	ACTIVE	DSBGA	YKE	4	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	U	Samples
LP5907UVE-2.85/NOPB	ACTIVE	DSBGA	YKE	4	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	V	Samples
LP5907UVE-3.0/NOPB	ACTIVE	DSBGA	YKE	4	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	В	Samples
LP5907UVE-3.1/NOPB	ACTIVE	DSBGA	YKE	4	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	Х	Samples
LP5907UVE-3.2/NOPB	ACTIVE	DSBGA	YKE	4	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	С	Samples
LP5907UVE-3.3/NOPB	ACTIVE	DSBGA	YKE	4	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	D	Sample





15-Apr-2017

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
LP5907UVE-4.5/NOPB	ACTIVE	DSBGA	YKE	4	250	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	Z	Samples
LP5907UVX-1.2/NOPB	ACTIVE	DSBGA	YKE	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	R	Samples
LP5907UVX-1.8/NOPB	ACTIVE	DSBGA	YKE	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	S	Samples
LP5907UVX-2.5/NOPB	ACTIVE	DSBGA	YKE	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	Е	Samples
LP5907UVX-2.8/NOPB	ACTIVE	DSBGA	YKE	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	U	Samples
LP5907UVX-2.85/NOPB	ACTIVE	DSBGA	YKE	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	V	Samples
LP5907UVX-3.0/NOPB	ACTIVE	DSBGA	YKE	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	В	Samples
LP5907UVX-3.1/NOPB	ACTIVE	DSBGA	YKE	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	Х	Samples
LP5907UVX-3.2/NOPB	ACTIVE	DSBGA	YKE	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	С	Samples
LP5907UVX-3.3/NOPB	ACTIVE	DSBGA	YKE	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	D	Samples
LP5907UVX-4.5/NOPB	ACTIVE	DSBGA	YKE	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	Z	Samples
LP5907UVX19/NOPB	ACTIVE	DSBGA	YKE	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	8	Samples
LP5907UVX37/NOPB	ACTIVE	DSBGA	YKE	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 125	9	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW**: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



# PACKAGE OPTION ADDENDUM

15-Apr-2017

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF LP5907:

Automotive: LP5907-Q1

NOTE: Qualified Version Definitions:

Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

**PACKAGE MATERIALS INFORMATION** 

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# TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LP5907MFX-1.2/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP5907MFX-1.5/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP5907MFX-1.8/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP5907MFX-2.5/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP5907MFX-2.8/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP5907MFX-2.85/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP5907MFX-3.0/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP5907MFX-3.1/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP5907MFX-3.2/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP5907MFX-3.3/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP5907MFX-4.5/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LP5907SNX-1.2/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-1.8/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-1.9	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-2.2/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-2.5/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-2.7/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-2.75	X2SON	DQN	4	3000	180.0	8.4	1.16	1.16	0.63	4.0	8.0	Q2



# **PACKAGE MATERIALS INFORMATION**

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Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LP5907SNX-2.75	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-2.8/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-2.85/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-2.85/NOPB	X2SON	DQN	4	3000	180.0	8.4	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-2.9/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-3.0/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-3.1/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-3.2/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-3.3/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-4.0/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907SNX-4.5/NOPB	X2SON	DQN	4	3000	180.0	9.5	1.16	1.16	0.63	4.0	8.0	Q2
LP5907UVE-1.2/NOPB	DSBGA	YKE	4	250	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVE-1.8/NOPB	DSBGA	YKE	4	250	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVE-2.8/NOPB	DSBGA	YKE	4	250	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVE-2.85/NOPB	DSBGA	YKE	4	250	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVE-3.0/NOPB	DSBGA	YKE	4	250	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVE-3.1/NOPB	DSBGA	YKE	4	250	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVE-3.2/NOPB	DSBGA	YKE	4	250	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVE-3.3/NOPB	DSBGA	YKE	4	250	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVE-4.5/NOPB	DSBGA	YKE	4	250	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVX-1.2/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVX-1.8/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVX-1.8/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.7	0.7	0.48	4.0	8.0	Q1
LP5907UVX-2.5/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVX-2.8/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVX-2.85/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.7	0.7	0.48	4.0	8.0	Q1
LP5907UVX-2.85/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVX-3.0/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVX-3.1/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVX-3.2/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVX-3.3/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVX-4.5/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVX19/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.7	0.7	0.48	4.0	8.0	Q1
LP5907UVX19/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1
LP5907UVX37/NOPB	DSBGA	YKE	4	3000	178.0	8.4	0.71	0.71	0.51	4.0	8.0	Q1



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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LP5907MFX-1.2/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP5907MFX-1.5/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP5907MFX-1.8/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP5907MFX-2.5/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP5907MFX-2.8/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP5907MFX-2.85/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP5907MFX-3.0/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP5907MFX-3.1/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP5907MFX-3.2/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP5907MFX-3.3/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP5907MFX-4.5/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LP5907SNX-1.2/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-1.8/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-1.9	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-2.2/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-2.5/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-2.7/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-2.75	X2SON	DQN	4	3000	202.0	201.0	28.0
LP5907SNX-2.75	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-2.8/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0



# **PACKAGE MATERIALS INFORMATION**

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LP5907SNX-2.85/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-2.85/NOPB	X2SON	DQN	4	3000	202.0	201.0	28.0
LP5907SNX-2.9/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-3.0/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-3.1/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-3.2/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-3.3/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-4.0/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907SNX-4.5/NOPB	X2SON	DQN	4	3000	184.0	184.0	19.0
LP5907UVE-1.2/NOPB	DSBGA	YKE	4	250	210.0	185.0	35.0
LP5907UVE-1.8/NOPB	DSBGA	YKE	4	250	210.0	185.0	35.0
LP5907UVE-2.8/NOPB	DSBGA	YKE	4	250	210.0	185.0	35.0
LP5907UVE-2.85/NOPB	DSBGA	YKE	4	250	210.0	185.0	35.0
LP5907UVE-3.0/NOPB	DSBGA	YKE	4	250	210.0	185.0	35.0
LP5907UVE-3.1/NOPB	DSBGA	YKE	4	250	210.0	185.0	35.0
LP5907UVE-3.2/NOPB	DSBGA	YKE	4	250	210.0	185.0	35.0
LP5907UVE-3.3/NOPB	DSBGA	YKE	4	250	210.0	185.0	35.0
LP5907UVE-4.5/NOPB	DSBGA	YKE	4	250	210.0	185.0	35.0
LP5907UVX-1.2/NOPB	DSBGA	YKE	4	3000	210.0	185.0	35.0
LP5907UVX-1.8/NOPB	DSBGA	YKE	4	3000	210.0	185.0	35.0
LP5907UVX-1.8/NOPB	DSBGA	YKE	4	3000	220.0	220.0	35.0
LP5907UVX-2.5/NOPB	DSBGA	YKE	4	3000	210.0	185.0	35.0
LP5907UVX-2.8/NOPB	DSBGA	YKE	4	3000	210.0	185.0	35.0
LP5907UVX-2.85/NOPB	DSBGA	YKE	4	3000	220.0	220.0	35.0
LP5907UVX-2.85/NOPB	DSBGA	YKE	4	3000	210.0	185.0	35.0
LP5907UVX-3.0/NOPB	DSBGA	YKE	4	3000	210.0	185.0	35.0
LP5907UVX-3.1/NOPB	DSBGA	YKE	4	3000	210.0	185.0	35.0
LP5907UVX-3.2/NOPB	DSBGA	YKE	4	3000	210.0	185.0	35.0
LP5907UVX-3.3/NOPB	DSBGA	YKE	4	3000	210.0	185.0	35.0
LP5907UVX-4.5/NOPB	DSBGA	YKE	4	3000	210.0	185.0	35.0
LP5907UVX19/NOPB	DSBGA	YKE	4	3000	220.0	220.0	35.0
LP5907UVX19/NOPB	DSBGA	YKE	4	3000	210.0	185.0	35.0
LP5907UVX37/NOPB	DSBGA	YKE	4	3000	210.0	185.0	35.0

DBV (R-PDSO-G5)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-178 Variation AA.



# DBV (R-PDSO-G5)

# PLASTIC SMALL OUTLINE



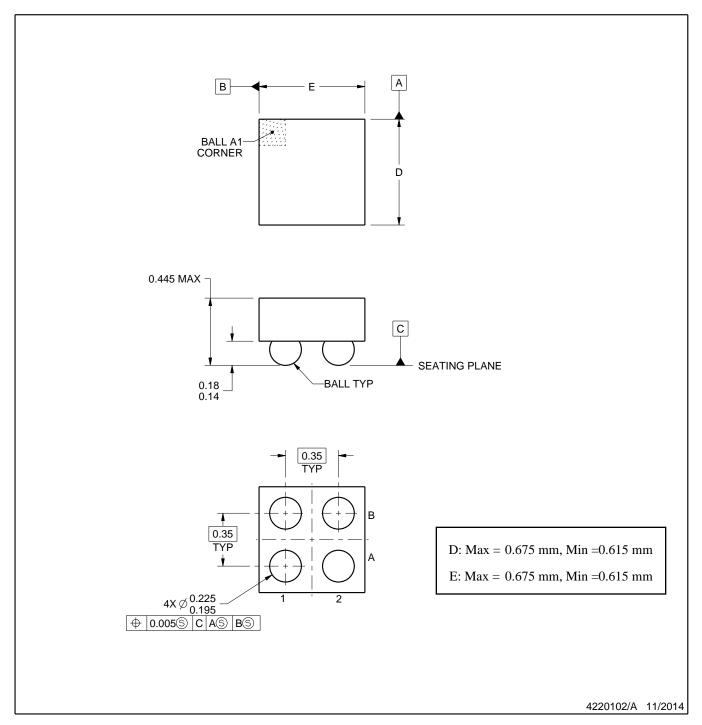
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.





DIE SIZE BALL GRID ARRAY



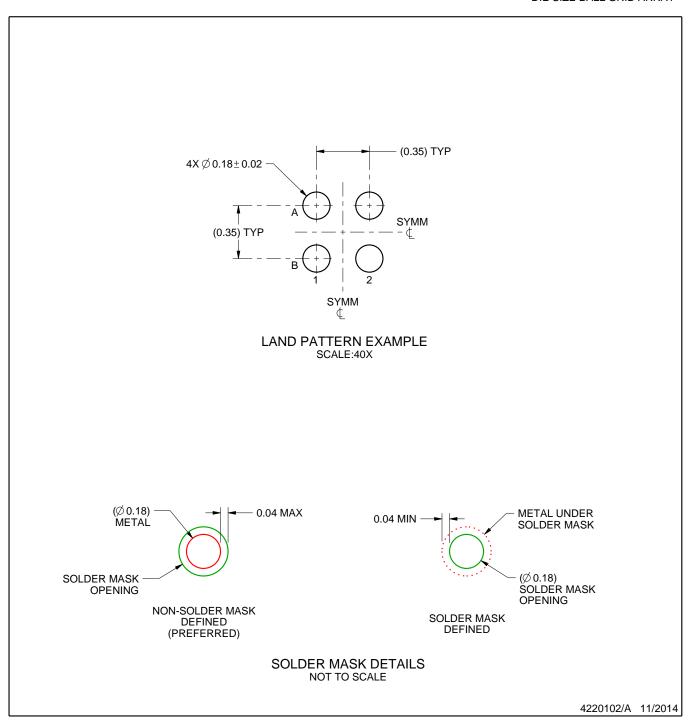
# NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.



DIE SIZE BALL GRID ARRAY

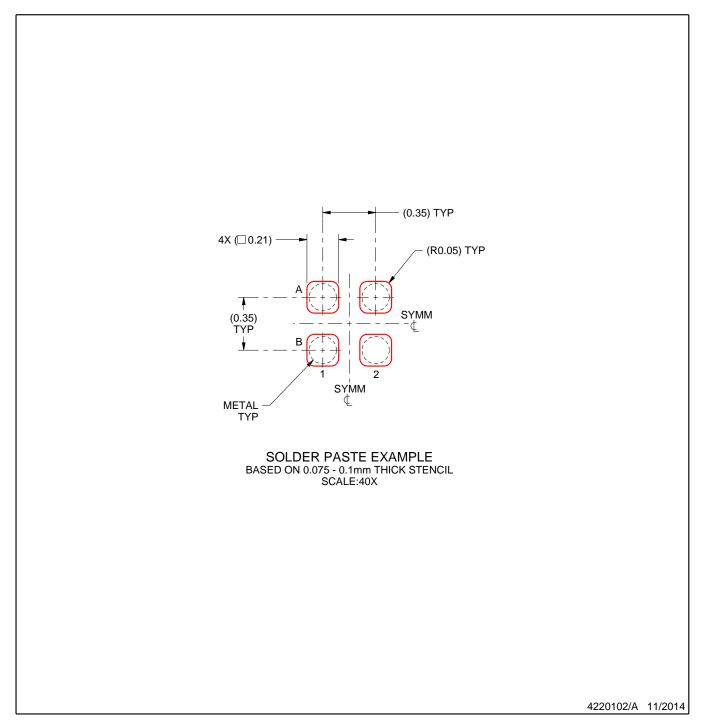


NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. Refer to Texas Instruments Literature No. SNVA009 (www.ti.com/lit/snva009).



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



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